

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/791,504	CHIANG ET AL.	
Examiner	Art Unit	<u>-</u> 4.
Anish Desai	1771	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor search using EAST	7/7/2007	APD	
29/886, 264/436,367/170,369,144,381/191 (Text search only USPGPUB, USPAT)	7/2/2007	APD	
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